

<b>Notice of References Cited</b>	Application/Control No. 10/016,434	Applicant(s)/Patent Under Reexamination TANIGAWA ET AL.	
	Examiner Annan Q. Shang	Art Unit 2617	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,832,385	12-2004	Young et al.	725/39
*	B	US-5,477,262	12-1995	Banker et al.	725/38
*	C	US-5,479,268	12-1995	Young et al.	386/83
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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